

Supporting Information

for

Functionalized TiO₂ nanoparticles by single-step hydrothermal synthesis: the role of the silane coupling agents

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Additional experimental data

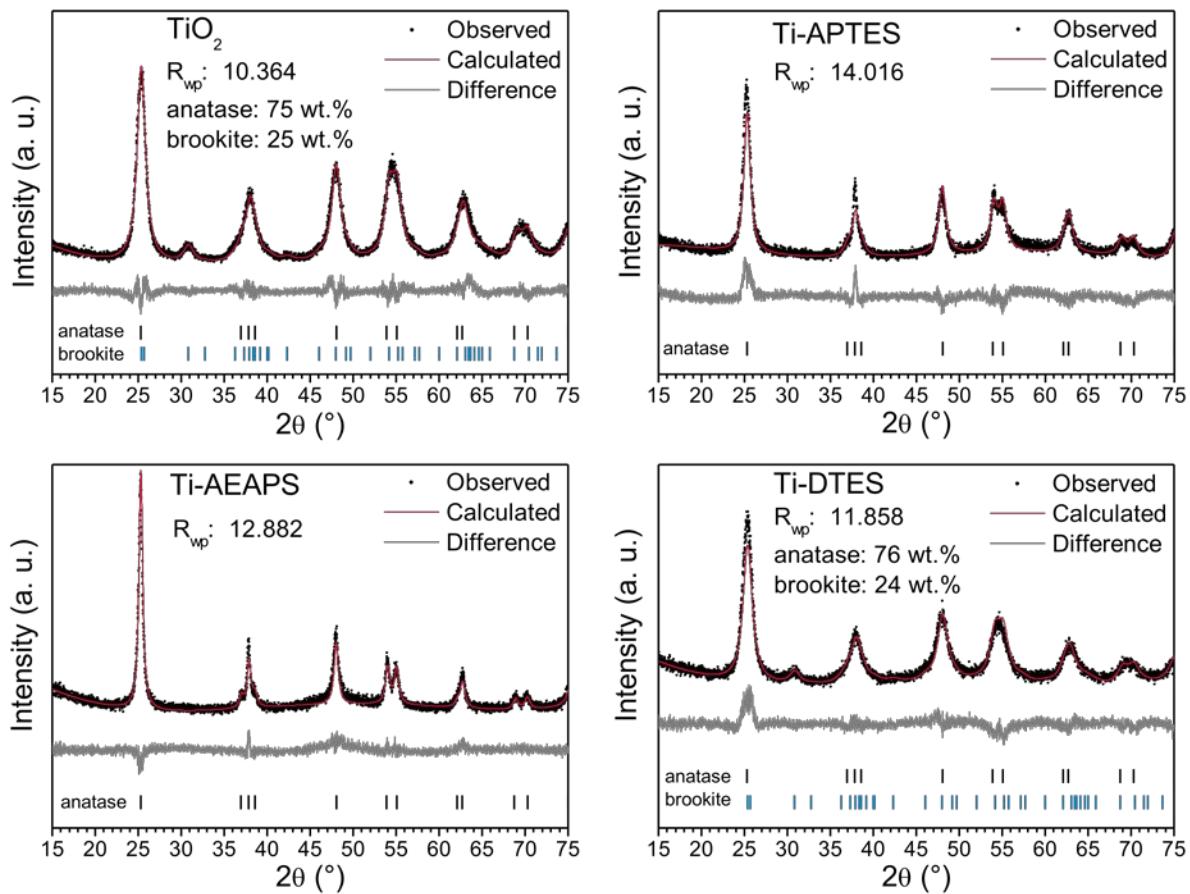


Figure S1: Rietveld refinements of TiO₂ and in situ surface-functionalized TiO₂ nanoparticles diffractograms (bars show diffraction lines of anatase from ICDD card #00-021-1272 and brookite from ICDD card #00-029-1360).

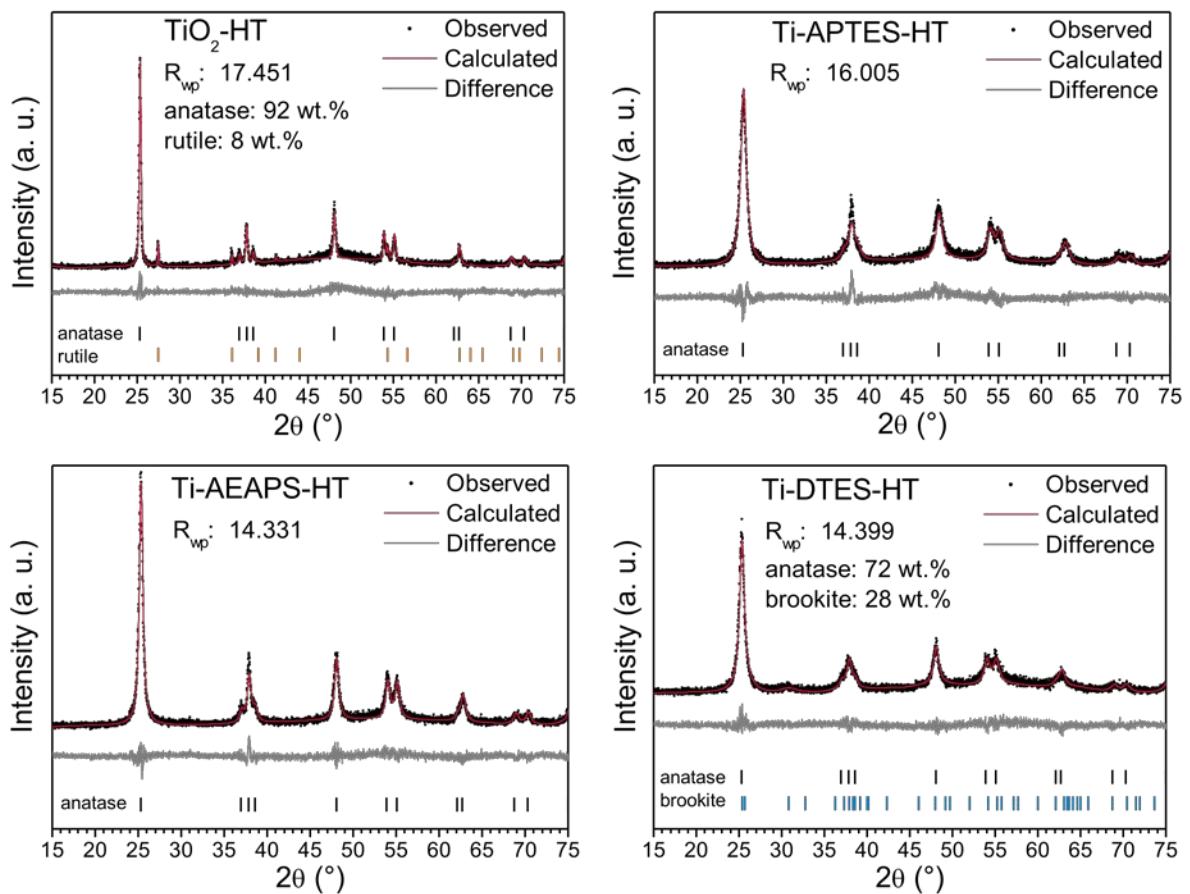


Figure S2: Rietveld refinements of heat treated TiO₂ and in situ surface-functionalized TiO₂ nanoparticles diffractograms (bars show diffraction lines of anatase from ICDD card #00-021-1272, brookite from ICDD card #00-029-1360, and rutile from ICDD card #00-021-1276).

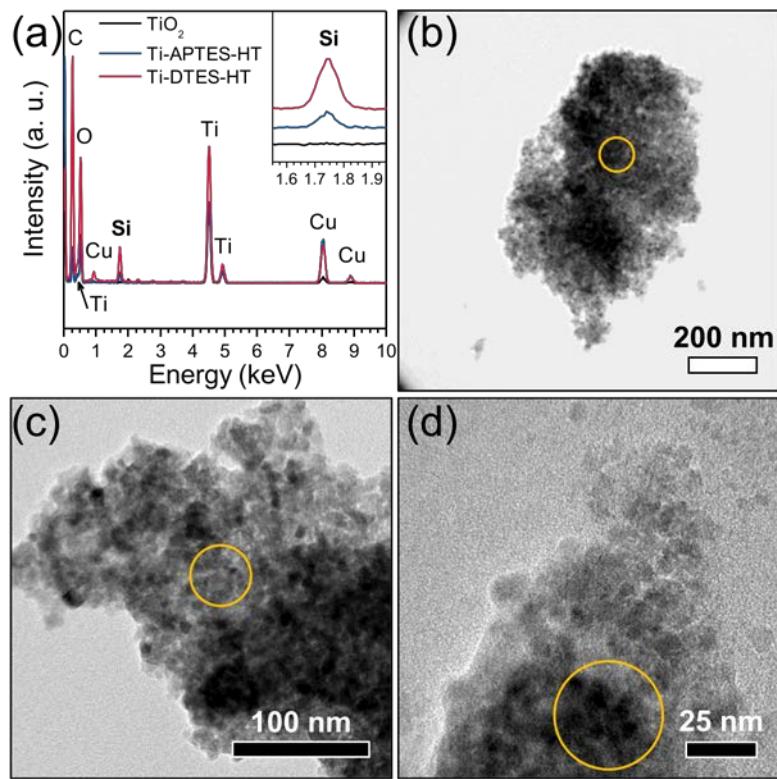


Figure S3: (a) EDS spectra from samples area (yellow circles) shown on TEM images of (b) TiO_2 , (c) Ti-APTES-HT, and (d) Ti-DTES-HT, respectively.

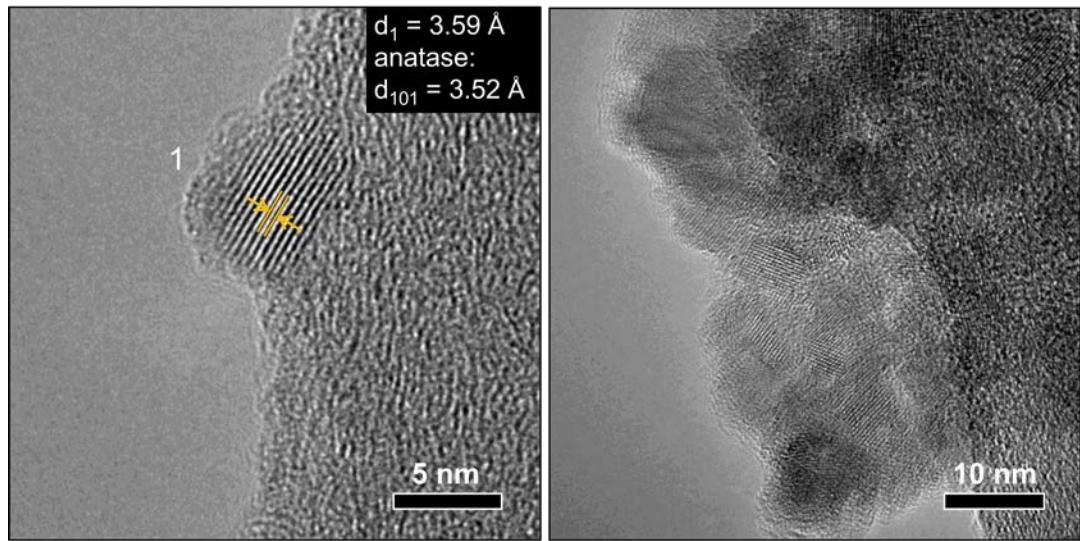


Figure S4: HR-TEM images of Ti-APTES-HT.

Table S1: Assignments of characteristic IR-bands of TiO₂ and *in situ* surface functionalized TiO₂ nanoparticles.

wave number (cm ⁻¹)	assignment	sample	references
<900	Ti–O–Ti	all	[1-4]
910	Ti–O–Si	all functionalized samples	[1-6]
1020 and 1120	Si–O–Si	all functionalized samples	[1-8]
1220	Si–CH ₂ R	all functionalized samples	[3,5,8]
1260	Si–CH ₃	Ti-AEAPS	[3,5,9]
1380	CH ₃ (deformation)	Ti-DTES	[3]
1460	CH ₂ (deformation)	all functionalized samples	[3,8,10]
1530 and 3200–3500	N–H	Ti-APTES, Ti-AEAPS	[1,3,8,10]
1640 and 2500–3600	adsorbed H ₂ O and OH groups	all	[1,3,7,8]
2850 and 2920	CH ₂ (stretching)	all functionalized samples	[1-3,8,11]
2870 and 2960	CH ₃ (stretching)	Ti-DTES	[3,11]

References

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